

### N-channel 800 V, 0.29 Ω typ., 14 A MDmesh™ K5 Power MOSFET in a TO-220FP package

Datasheet - production data

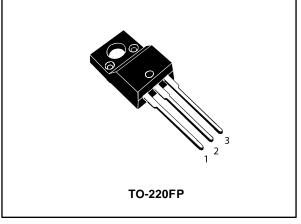
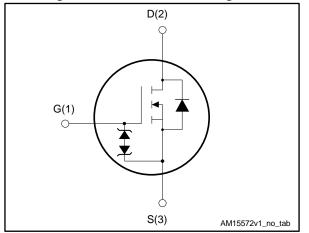


Figure 1: Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max.	ID
STF17N80K5	800 V	0.34 Ω	14 A

- Industry's lowest R<sub>DS(on)</sub> x area
- Industry's best figure of merit (FoM)
- Ultra-low gate charge
- 100% avalanche tested
- Zener-protected

### **Applications**

• Switching applications

### Description

This very high voltage N-channel Power MOSFET is designed using MDmesh<sup>™</sup> K5 technology based on an innovative proprietary vertical structure. The result is a dramatic reduction in on-resistance and ultra-low gate charge for applications requiring superior power density and high efficiency.

#### Table 1: Device summary

Order code	Marking	Package	Packing
STF17N80K5	17N80K5	TO-220FP	Tube

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This is information on a product in full production.

#### Contents

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### 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>GS</sub>	Gate-source voltage	± 30	V
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 25 °C	14	А
I <sub>D</sub> <sup>(1)</sup>	Drain current (continuous) at T <sub>C</sub> = 100 °C	9	А
I <sub>DM</sub> <sup>(2)</sup>	Drain current (pulsed)	56	А
P <sub>TOT</sub>	Total dissipation at $T_C = 25 \text{ °C}$	30	W
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t=1 s; $T_C$ =25 °C)	2500	V
dv/dt <sup>(3)</sup>	Peak diode recovery voltage slope	4.5	)//
dv/dt <sup>(4)</sup>	MOSFET dv/dt ruggedness	50	V/ns
TJ	Operating junction temperature range	- 55 to 150	.0°
T <sub>stg</sub>	Storage temperature range	- 55 10 150	C

#### Notes:

<sup>(1)</sup>Limited by maximum junction temperature.

 $^{\rm (2)} {\rm Pulse}$  width limited by safe operating area

 $^{(3)}I_{SD} \leq$  14 A, di/dt 100 A/µs; V\_Ds peak < V\_{(BR)DSS},V\_DD= 400 V

 $^{(4)}V_{DS} \le 640 \text{ V}$ 

#### Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case	4.2	°C/W
R <sub>thj-amb</sub>	Thermal resistance junction-ambient	62.5	°C/W

#### Table 4: Avalanche characteristics

Symbol	Parameter	Value	Unit
I <sub>AR</sub>	Avalanche current, repetitive or not repetitive (pulse width limited by $T_{jmax})$	4.7	А
E <sub>AS</sub>	Single pulse avalanche energy (starting Tj = 25 °C, I_D = I_{AR}, V_{DD} = 50 V)	340	mJ



### 2 Electrical characteristics

 $T_C = 25$  °C unless otherwise specified

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	$V_{GS} = 0 V, I_D = 1 mA$	800			V
	$V_{GS} = 0 V, V_{DS} = 800 V$			1	μA	
I <sub>DSS</sub>	Zero gate voltage drain current	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 800 V T <sub>C</sub> = 125 °C			50	μA
I <sub>GSS</sub>	Gate body leakage current	$V_{DS}$ = 0 V, $V_{GS}$ = ±25 V			±10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DD}$ = $V_{GS}$ , $I_D$ = 250 $\mu$ A	3	4	5	V
R <sub>DS(on)</sub>	Static drain-source on-resistance	$V_{GS}$ = 10 V, $I_{D}$ = 7 A		0.29	0.34	Ω

#### Table 5: On/off-state

#### Table 6: Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Ciss	Input capacitance		-	866	-	pF
C <sub>oss</sub>	Output capacitance	$V_{DS} = 100 \text{ V}, \text{ f} = 1 \text{ MHz},$ $V_{GS} = 0 \text{ V}$	-	64	-	pF
C <sub>rss</sub>	Reverse transfer capacitance	163 - 0 1	-	0.42	-	pF
C <sub>o(tr)</sub> <sup>(1)</sup>	Equivalent capacitance time related	V <sub>DS</sub> = 0 to 640 V,	-	142	-	pF
C <sub>o(er)</sub> <sup>(2)</sup>	Equivalent capacitance energy related	$V_{GS} = 0 V$	-	51	-	pF
Rg	Intrinsic gate resistance	$f = 1 \text{ MHz}$ , $I_D = 0 \text{ A}$	-	5	-	Ω
Qg	Total gate charge	$V_{DD} = 640 \text{ V}, \text{ I}_{D} = 14 \text{ A}$	-	26	-	nC
Q <sub>gs</sub>	Gate-source charge	V <sub>GS</sub> = 10 V	-	7.2	-	nC
Q <sub>gd</sub>	Gate-drain charge	See (Figure 15: "Test circuit for gate charge behavior")	-	15.2	-	nC

#### Notes:

 $^{(1)}$  Time related is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

 $^{(2)}\mathsf{E}\mathsf{nergy}$  related is defined as a constant equivalent capacitance giving the same stored energy as  $C_{oss}$  when  $\mathsf{V}_{DS}$  increases from 0 to 80%  $\mathsf{V}_{DSS}$ 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time	$V_{\text{DD}}\text{=}\;400$ V, $I_{\text{D}}$ =7 A, $R_{\text{G}}$ = 4.7 $\Omega$	-	14.8	-	ns
tr	Rise time	V <sub>GS</sub> = 10 V	-	10.8	-	ns
t <sub>d(off)</sub>	Turn-off delay time	See (Figure 14: "Test circuit for resistive load switching times" and	-	84.3	-	ns
t <sub>f</sub>	Fall time	Figure 19: "Switching time waveform")	-	10.1	-	ns

Table 7: Switching times





#### Electrical characteristics

	Table 8: Source-drain diode							
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit		
I <sub>SD</sub>	Source-drain current		-		14	А		
I <sub>SDM</sub> <sup>(1)</sup>	Source-drain current (pulsed)		-		56	А		
V <sub>SD</sub> <sup>(2)</sup>	Forward on voltage	$I_{SD}$ = 14 A, $V_{GS}$ = 0 V	-		1.6	V		
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 14 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}, \text{V}_{DD}$	-	439		ns		
Q <sub>rr</sub>	Reverrse recovery charge	= 60 V See Figure 16: "Test circuit for	-	6.37		μC		
I <sub>RRM</sub>	Reverse recovery current	inductive load switching and diode recovery times"	-	29		А		
t <sub>rr</sub>	Reverse recovery time	$I_{SD} = 14 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s V}_{DD}$	-	626		ns		
Qrr	Reverse recovery charge	= 60 V, T <sub>j</sub> = 150 °C See Figure 16: "Test circuit for inductive load switching and diode recovery times"	-	8.36		μC		
I <sub>RRM</sub>	Reverse recovery current		-	26.7		А		

#### Notes:

 $^{(1)}\mbox{Pulse}$  width limited by safe operating area

 $^{(2)}\text{Pulsed:}$  pulse duration = 300  $\mu\text{s},$  duty cycle 1.5%

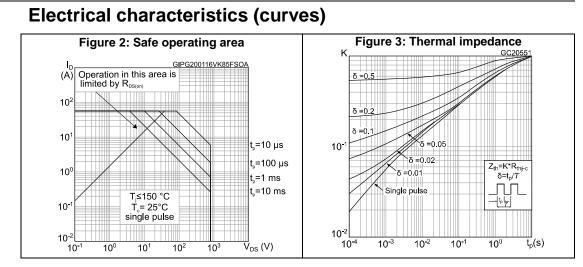
#### Table 9: Gate-source Zener diode

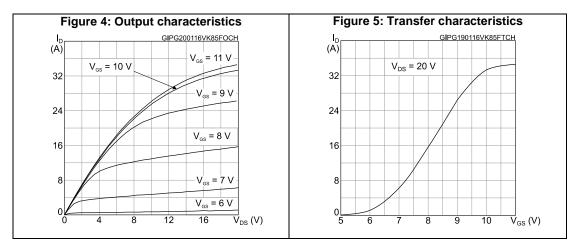
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS}$ = ± 1mA, $I_{D}$ = 0 A	30	-	-	V

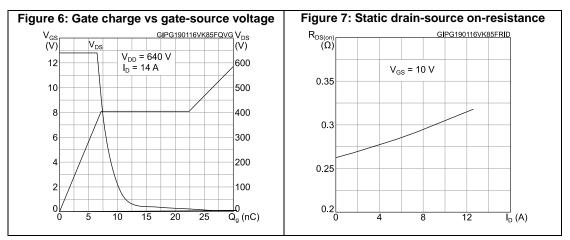
The built-in back-to-back Zener diodes are specifically designed to enhance the ESD performance of the device. The Zener voltage facilitates efficient and cost-effective device integrity protection, thus eliminating the need for additional external componentry.



2.2



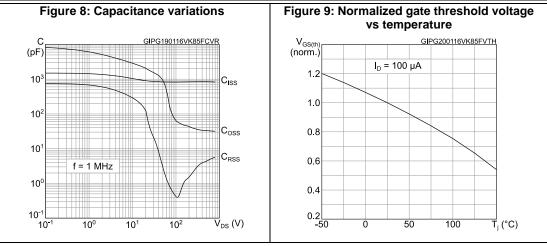


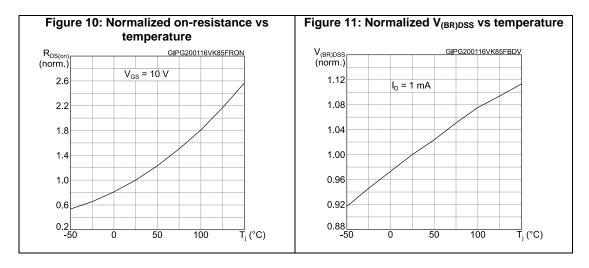


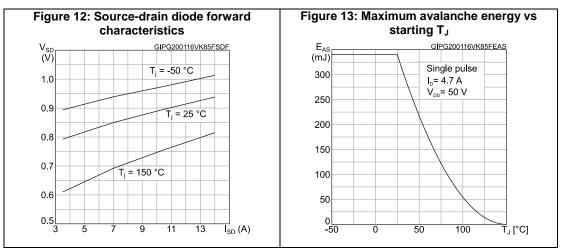
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#### **Electrical characteristics**

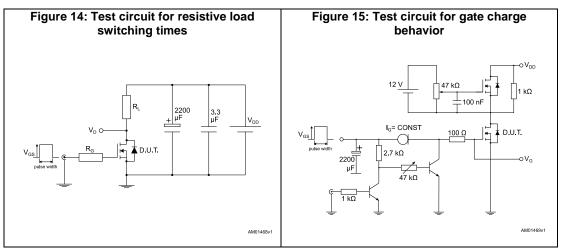


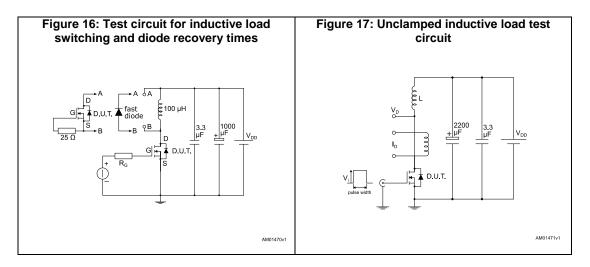


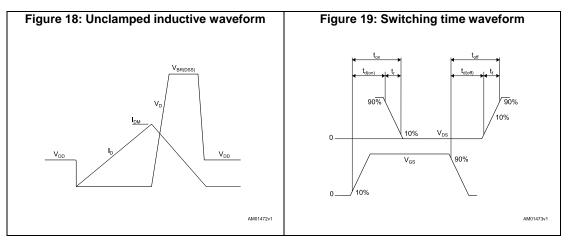


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### 3 Test circuits







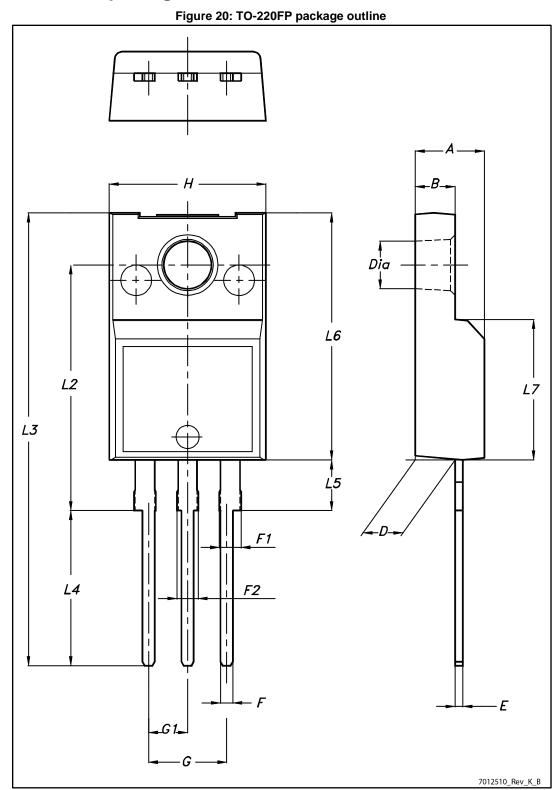


### 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.









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K5			Package information
	Table 10: TO-220FP pa	ickage mechanical data	
Dim.		mm	
Dim.	Min.	Тур.	Max.
А	4.4		4.6
В	2.5		2.7
D	2.5		2.75
E	0.45		0.7
F	0.75		1
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.2
G1	2.4		2.7
н	10		10.4
L2		16	
L3	28.6		30.6
L4	9.8		10.6
L5	2.9		3.6
L6	15.9		16.4
L7	9		9.3
Dia	3		3.2



#### **Revision history** 5

Date	Revision	Changes
31-Mar-2015	1	First release.
20-Jan-2016	2	Modified: Table 4: "Avalanche characteristics", Table 6: "Dynamic", Table 7: "Switching times", and Table 8: "Source-drain diode" Added: Section 3.1: "Electrical characteristics (curves)" Minor text changes



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